

Notice of References Cited	Application/Control No. 10/535,423		Applicant(s)/Patent Under Reexamination OKAHARA ET AL.	
	Examiner EDMUND H. LEE		Art Unit 1791	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,676,901	10-1997	Higashi et al.	264/255
*	C	US-6,676,877	01-2004	Thompson, John A.	264/255
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	L	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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